## IRLZ44

Vishay Siliconix



**TO-220AB** 

**PRODUCT SUMMARY** 

V<sub>DS</sub> (V)

 $R_{DS(on)}(\Omega)$ 

Q<sub>qs</sub> (nC)

Q<sub>qd</sub> (nC)

Q<sub>a</sub> (Max.) (nC)

Configuration

# **Power MOSFET**

S

N-Channel MOSFET

0.028

60

66

12

43

Single

 $V_{GS} = 5.0 V$ 

### FEATURES

- Dynamic dV/dt rating
- Logic-level gate drive
- R<sub>DS(on)</sub> specified at V<sub>GS</sub> = 4 V and 5 V
- 175 °C operating temperature
- Fast switching
- Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

#### DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION            |               |
|---------------------------------|---------------|
| Package                         | TO-220AB      |
| Lead (Pb)-free                  | IRLZ44PbF     |
| Lead (Pb)-free and halogen-free | IRLZ44PbF-BE3 |

| <b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25 \degree C$ , unless otherwise noted) |                        |  |                  |       |          |      |  |  |  |
|--|------------------------|--|------------------|-------|----------|------|--|--|--|
| PARAMETER  |                        |  | SYMBOL           | LIMIT | UNIT     |      |  |  |  |
| Drain-source voltage   |                        | V <sub>DS</sub>                                  | 60               | - V   |          |      |  |  |  |
| Gate-source voltage  |                        |  | V <sub>GS</sub>  |       |          | ± 10 |  |  |  |
| Continuous drain current   | V <sub>GS</sub> at 5 V | $T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$ | - I <sub>D</sub> | 50    |          |      |  |  |  |
|  |                        | T <sub>C</sub> = 100 °C                          |                  | 36    | А        |      |  |  |  |
| Pulsed drain current <sup>a</sup>  |                        |  | I <sub>DM</sub>  | 200   | 1        |      |  |  |  |
| Linear derating factor   |                        |  | 1.0              | W/°C  |          |      |  |  |  |
| Single pulse avalanche energy <sup>b</sup>                                       |                        | E <sub>AS</sub>                                  | 400              | mJ    |          |      |  |  |  |
| Maximum power dissipation  | T <sub>C</sub> = 25 °C |  | PD               | 150   | W        |      |  |  |  |
| Peak diode recovery dV/dt <sup>c</sup>   |                        |  | dV/dt            | 4.5   | V/ns     |      |  |  |  |
| Operating junction and storage temperature range                                 |                        | T <sub>J</sub> , T <sub>stg</sub>                | -55 to +175      | *0    |          |      |  |  |  |
| Soldering recommendations (peak temperature) <sup>d</sup>                        | For 10 s               |  |                  | 300   | - °C     |      |  |  |  |
| Mounting torque  | 6-32 or M3 screw       |  |                  | 10    | lbf ∙ in |      |  |  |  |
|  |                        |  |                  | 1.1   | N·m      |      |  |  |  |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 179 µH,  $R_q = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12)

c.  $I_{SD} \le 51$  A, dV/dt  $\le 250$  A/s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C

d. 1.6 mm from case

e. Current limited by the package, (die current = 51 A)

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| THERMAL RESISTANCE RATI                   | NGS                    |  |                             |                   |                      |                  |       |      |
|---|------------------------|--|-----------------------------|-------------------|----------------------|------------------|-------|------|
| PARAMETER                                 | SYMBOL                 | . т  | TYP.                        |                   | MAX.                 |                  | UNIT  |      |
| Maximum junction-to-ambient               | R <sub>thJA</sub>      |  | -                           | 6                 | 62                   |                  |       |      |
| Case-to-sink, flat, greased surface       | R <sub>thCS</sub>      | 0.50 -   |                             | -                 |                      | °C/W             |       |      |
| Maximum junction-to-case (drain)          | R <sub>thJC</sub>      | - 1  |                             |                   | .0                   |                  |       |      |
|   |                        |  |                             |                   |                      |                  |       |      |
| SPECIFICATIONS (T <sub>J</sub> = 25 °C, u | nless otherwi          | ise noted)   |                             |                   |                      |                  |       |      |
| PARAMETER                                 | SYMBOL                 | TEST CONDITIONS  |                             |                   | MIN.                 | TYP.             | MAX.  | UNIT |
| Static                                    |                        |  |                             |                   | <u> </u>             | I                | I     | 1    |
| Drain-source breakdown voltage            | V <sub>DS</sub>        | V <sub>GS</sub> = 0  | V, I <sub>D</sub> = 250 μA  |                   | 60                   | -                | -     | V    |
| V <sub>DS</sub> temperature coefficient   | $\Delta V_{DS}/T_{J}$  | Reference t  | o 25 °C, I <sub>D</sub> = 1 | mA                | -                    | 0.070            | -     | V/°C |
| Gate-source threshold voltage             | V <sub>GS(th)</sub>    | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                              |                             |                   | 1.0                  | -                | 2.0   | V    |
| Gate-source leakage                       | I <sub>GSS</sub>       | V <sub>GS</sub> = 10 V   |                             |                   | -                    | -                | ± 100 | nA   |
|   |                        | $V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$                                    |                             | -                 | -                    | 25               | μA    |      |
| Zero gate voltage drain current           | I <sub>DSS</sub>       | V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C                   |                             |                   | -                    | -                |       | 250  |
| Drain-source on-state resistance          | 5                      | V <sub>GS</sub> = 5.0 V  | I <sub>D</sub> = 31         | Ab                | -                    | -                | 0.028 | Ω    |
|   | R <sub>DS(on)</sub>    | V <sub>GS</sub> = 4.0 V  | I <sub>D</sub> = 25         | Ab                | -                    | -                | 0.039 |      |
| Forward transconductance                  | <b>g</b> <sub>fs</sub> | V <sub>DS</sub> = 25 V, I <sub>D</sub> = 31 A <sup>b</sup>                               |                             |                   | 23                   | -                | -     | S    |
| Dynamic                                   |                        |  |                             |                   |                      |                  |       |      |
| Input capacitance                         | C <sub>iss</sub>       | V  | -                           | 3300              | -                    | pF               |       |      |
| Output capacitance                        | C <sub>oss</sub>       | $V_{GS} = 0 V,$<br>$V_{DS} = 25 V,$  |                             | -                 | 1200                 |                  | -     |      |
| Reverse transfer capacitance              | C <sub>rss</sub>       | f = 1.0 MHz, see fig. 5  |                             |                   | -                    |                  | 200   | -    |
| Total gate charge                         | Qg                     |  |                             | -                 | -                    | 66               | nC    |      |
| Gate-source charge                        | Q <sub>gs</sub>        | $V_{GS} = 5.0 V$ $I_D = 51 A, V_{DS} = 48$<br>see fig. 6 and 13                          |                             |                   | -                    | -                |       | 12   |
| Gate-drain charge                         | Q <sub>gd</sub>        |  | 300 lig. 0 a                | see lig. 0 and 15 |                      | -                |       | 43   |
| Turn-on delay time                        | t <sub>d(on)</sub>     | $V_{DD}$ = 30 V, $I_D$ = 51 A, $R_g$ = 4.6 $\Omega,R_D$ = 0.56 $\Omega,see$ fig. 10 $^b$ |                             |                   | -                    | 17               | -     | ns   |
| Rise time                                 | t <sub>r</sub>         |  |                             |                   | -                    | 230              | -     |      |
| Turn-off delay time                       | t <sub>d(off)</sub>    |  |                             |                   | -                    | 42               | -     |      |
| Fall time                                 | t <sub>f</sub>         |  |                             |                   | -                    | 110              | -     |      |
| Internal drain inductance                 | L <sub>D</sub>         | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact               |                             |                   | -                    | 4.5              | -     | nH   |
| Internal source inductance                | L <sub>S</sub>         |  |                             |                   | -                    | 7.5              | -     |      |
| Drain-Source Body Diode Characteristic    | s                      |  |                             |                   |                      |                  |       |      |
| Continuous source-drain diode current     | I <sub>S</sub>         | MOSFET symbol<br>showing the<br>integral reverse<br>p - n junction diode                 |                             |                   | -                    | -                | 50°   | A    |
| Pulsed diode forward current a            | I <sub>SM</sub>        |  |                             |                   | -                    | -                | 200   |      |
| Body diode voltage                        | $V_{SD}$               | $T_J$ = 25 °C, $I_S$ = 51 A, $V_{GS}$ = 0 V $^{\rm b}$                                   |                             |                   | -                    | -                | 2.5   | V    |
| Body diode reverse recovery time          | t <sub>rr</sub>        | $T_J = 25 \text{ °C}, I_F = 51 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}^{\text{b}}$  |                             |                   | -                    | 130              | 180   | ns   |
| Body diode reverse recovery charge        | Q <sub>rr</sub>        |  |                             |                   | -                    | 0.84             | 1.3   | μC   |
| Forward turn-on time                      | t <sub>on</sub>        | Intrinsic turn-  | I-on is doi                 | minated b         | y L <sub>S</sub> and | L <sub>D</sub> ) |       |      |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %

c. Current limited by the package, (die current = 51 A)

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

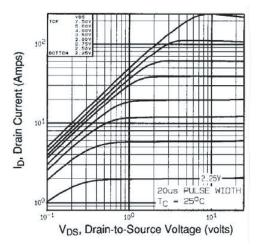


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

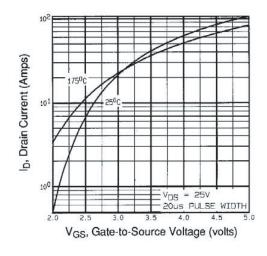


Fig. 3 - Typical Transfer Characteristics

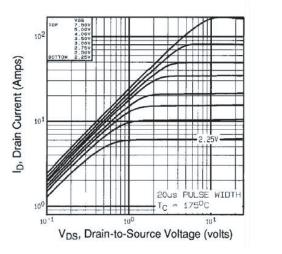


Fig. 2 - Typical Output Characteristics,  $T_C = 175 \ ^{\circ}C$ 

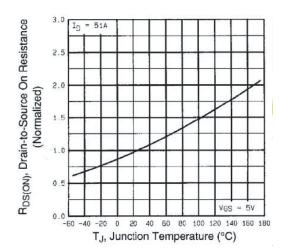
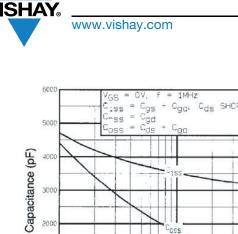


Fig. 4 - Normalized On-Resistance vs. Temperature

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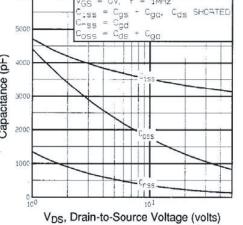


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

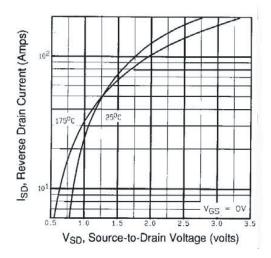


Fig. 7 - Typical Source-Drain Diode Forward Voltage

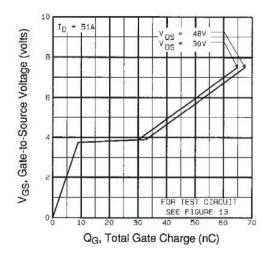


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

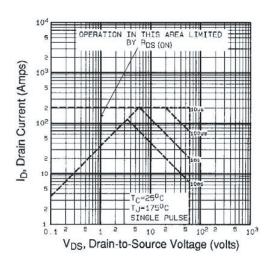


Fig. 8 - Maximum Safe Operating Area

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IRLZ44

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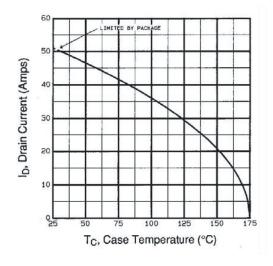


Fig. 9 - Maximum Drain Current vs. Case Temperature

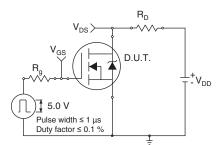


Fig. 10a - Switching Time Test Circuit

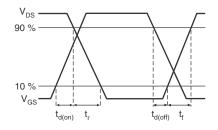


Fig. 10b - Switching Time Waveforms

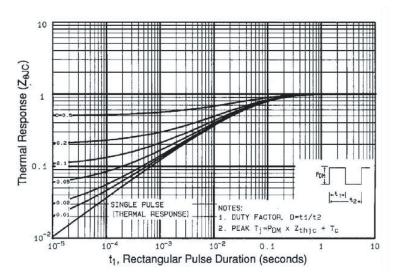


Fig. 10 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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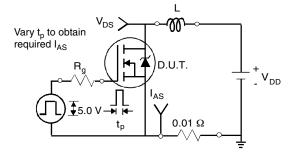


Fig. 12a - Unclamped Inductive Test Circuit

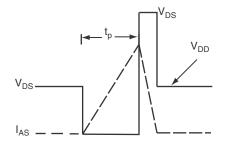


Fig. 12b - Unclamped Inductive Waveforms

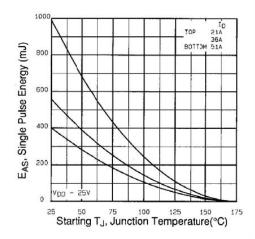


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

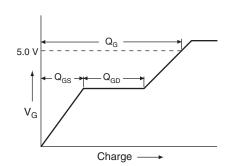
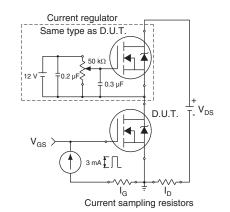


Fig. 13a - Basic Gate Charge Waveform





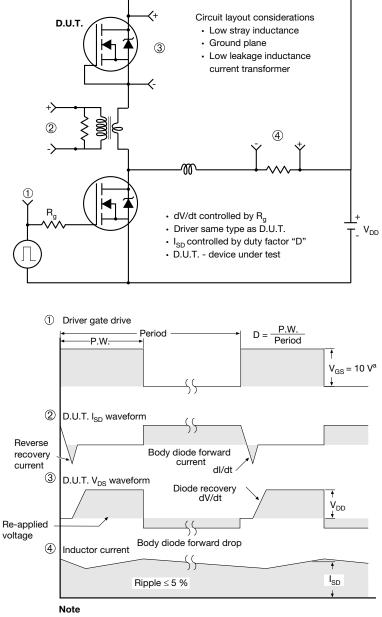
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#### Peak Diode Recovery dV/dt Test Circuit



a.  $V_{GS} = 5 V$  for logic level devices

Fig. 11 - For N-Channel

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